

**Search Notes**

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Junghwa M. Im

Applicant(s)/Patent under  
Reexamination

SHEN ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (uspat, uspub, epo, jpo, der, ibm)	7/21/2006	JMI
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